IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: LEE Attorney Docket No.: KLA1P012

Application No.: Unassigned Examiner: Unassigned

Filed: Herewith Group: Unassigned

Title: FILM THICKNESS MEASUREMENT

USING ELECTRON-BEAM INDUCED X-

RAY MICROANALYSIS

CERTIFICATE OF EXPRESS MAILING

I hereby certify that this paper and the documents and/or fees referred to as attached therein are being deposited with the United States Postal Service on October 23, 2000 in an envelope as "Express Mail Post Office to Addressee" service under 37 CFR §1.10, Mailing Label Number EL63104043US, addressed to the Assistant Commissioner for

Patents, Washington, DC 20231.

<u>INFORMATION DISCLOSURE STATEMENT</u> <u>UNDER 37 CFR §§1.56 AND 1,97(c)</u>

Assistant Commissioner for Patents Washington, DC 20231

Dear Sir:

The references listed in the attached PTO Form 1449, copies of which are attached, may be material to examination of the above-identified patent application. Applicants submit these references in compliance with their duty of disclosure pursuant to 37 CFR §§1.56 and 1.97. The Examiner is requested to make these references of official record in this application.

This Information Disclosure Statement is not to be construed as a representation that a search has been made, that additional information material to the examination of this application does not exist, or that these references indeed constitute prior art.

This Information Disclosure Statement is being filed within three (3) months of the filing date of the above-referenced application. Accordingly, it is believed that no fees are due in



connection with the filing of this Information Disclosure Statement. However, if it is determined that any fees are due, the Commissioner is hereby authorized to charge such fees to Deposit Account 500388 (Order No. KLA1P012).

Respectfully submitted,

BEYER WEAVER & THOMAS, LLP

Phillip P. Lee

Reg. No. 46,866

P.O. Box 778 Berkeley, CA 94704-0778 (650) 961-8300